Measurement Report for Device, , , UID 0 -, Channel 0 (2450.0MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 20.0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	,		, 0	2450.0, 0	8.18	1.84	40.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 217	HSL600-10000 Charge: xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29
	2023-May-09		

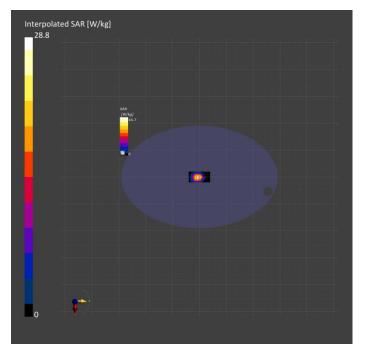
Scan Setup

Scan Setup			Measurement Resu	lts	
	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0	Date	2023-05-10, 08:59	2023-05-10, 09:05
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5	psSAR1g [W/kg]	14.7	14.1
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	6.93	6.62
Graded Grid	Yes	Yes	Power Drift [dB]	-0.09	-0.09
Grading Ratio	1.5	1.5	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		80.6
			Dist 3dB Peak [mm]		9.0

Warning(s) / Error(s)

Details Area Scan Warning(s) Error(s)

	14.7	14.1
]	6.93	6.62
	-0.09	-0.09
	Disabled	Disabled
B]		
	No correction	No correction
		80.6
nm]		9.0



Zoom Scan

Power drift exceeds warning threshold.

Measurement Report for Device, , , UID 0 -, Channel 0 (5250.0MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 20.0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	,		, 0	5250.0, 0	5.92	4.53	34.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2178	HSL600-10000 Charge: xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29
	2023-May-16		

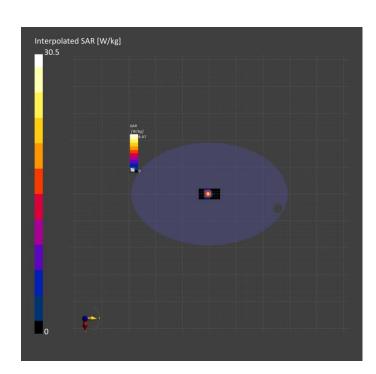
Scan Setup

Scan Setup	Measurement Results					
	Area Scan	Zoom Scan		Area Scan	Zoom Scan	
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0	Date	2023-05-16, 12:47	2023-05-16, 12:53	
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	psSAR1g [W/kg]	7.18	8.01	
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	2.20	2.34	
Graded Grid	Yes	Yes	Power Drift [dB]	-0.04	-0.01	
Grading Ratio	1.5	1.4	Power Scaling	Disabled	Disabled	
MAIA	N/A	N/A	Scaling Factor [dB]			
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction	
Scan Method	Measured	Measured	M2/M1 [%]		65.5	
			Dist 3dB Peak [mm]		7.2	

Zoom Scan

Warning(s) / Error(s)

Details Area Scan Warning(s) Error(s)



Measurement Report for Device, , , UID 0 -, Channel 0 (5750.0MHz)

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	50.0 x 10.0 x 20.0		Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	,		, 0	5750.0, 0	5.15	5.05	35.3

Hardware Setup

Phantom		TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 21	78	HSL600-10000 Charge: xxxx,	EX3DV4 - SN7733, 2022-08-02	DAE4 Sn1739, 2022-07-29
		2023-May-10		

Scan Setup

Scan Setup	Measurement Results				
-	Area Scan	Zoom Scan		Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0	Date	2023-05-10, 09:01	2023-05-10, 09:08
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	psSAR1g [W/kg]	6.92	7.65
Sensor Surface [mm]	3.0	1.4	psSAR10g [W/kg]	2.10	2.22
Graded Grid	Yes	Yes	Power Drift [dB]	-0.01	0.01
Grading Ratio	1.5	1.4	Power Scaling	Disabled	Disabled
MAIA	N/A	N/A	Scaling Factor [dB]		
Surface Detection	VMS + 6p	VMS + 6p	TSL Correction	No correction	No correction
Scan Method	Measured	Measured	M2/M1 [%]		62.3
			Dist 3dB Peak [mm]		7.4

Zoom Scan

Warning(s) / Error(s)

Details Area Scan Warning(s) Error(s)

